

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/554,921 MIURA ET AL.	
		Examiner	Art Unit	Page 1 of 1 Jeffrey T. Palenik 1615

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0047058	04-2002	Verhoff et al.	241/26
*	B	US-6,753,330	06-2004	Takano et al.	514/247
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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#### NON-PATENT DOCUMENTS

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